FORM PTO 1449 (modified)

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)

ATTY DOCKET NO."
03500.014088.1

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APPLICANT TAIKO MOTIO ET AL.

(Use several sheets if necessary)			FILING DATE FILED HEREWITH		GROUP 2879		
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
DD.	6,008,569	12/99	Yamanobe	313	310		
D.D.	6,005,334	12/99	Mitome et al.	313	309		
DD.	6,129,602	10/00	Yamanobe	445	24		
۵,۵.	6,147,449	11/00	lwasaki et al.	313	495		
. A. A	6,169,356	1/01	Ohnishi et al.	313	495		
D,D.	6,171,162	1/01	lwasaki et al.	445	6		
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A.A	6,184,610	2/01	Shibata et al.	313	309		
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D.D.	0901144	3/99	ЕРО			English	
D. D.	0701265	3/96	EPO			English	
D.D.	07065703	3/95	Japan			Abstract	
D.D.	2836015	10/98	Japan			Abstract	
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	DOCUMENT NUMBER	DATE	COUNTRY		CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
D.A.	2903295	3/99	Japan				Abstract
D.D.	7-235255	9/95	Japan				Abstract
D.D.	9-102267	4/97	Japan				Abstract
D.D.	8-273523	10/96	Japan				Abstract
D,A	8-102247	4/96	Japan				Abstract
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DATE CONSIDERED

Japan

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EPO

Abstract

Abstract

Yes

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*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE		
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